# ΗΙΟΚΙ

# BATTERY TESTER Series

## **Measuring Battery Quality**

Cells - Modules - Packs

## Quality Testing Maintenance Inspections R & D



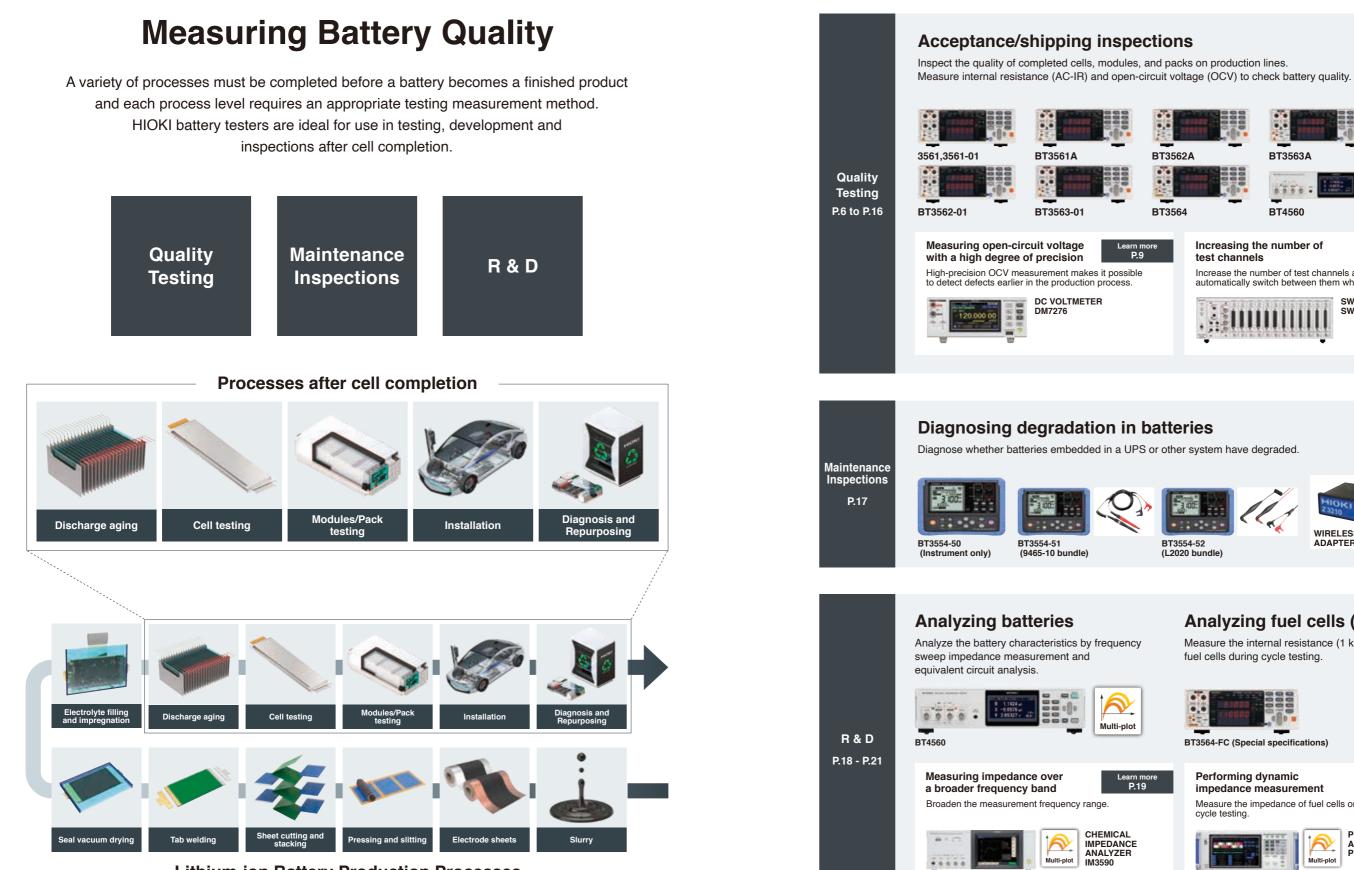




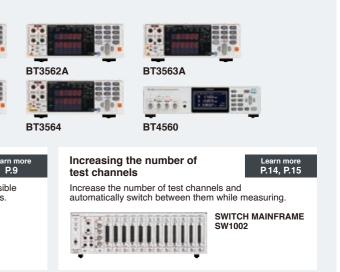




\*1: BT3561A, BT3562A, BT3563A, BT3562-01, BT3563-01 only \*2: BT3554-50, BT3554-51, BT3554-52 only



Lithium-ion Battery Production Processes



3



ANALYZER PW6001

## **Battery tester lineup**

			Acceptance/ship	ping inspections	
Application		Small cells for general purpose High speed sorting	Small cells for power motors Small packs of up to 60 V	Large cells for xEVs Mid-sized packs of up to 100 V	Large packs for xEVs Large packs of up to 300 V
Model		3561, 3561-01	BT3561A	BT3562A	BT3563A
			NEW	NEW	NEW
Appearance					
Measurement method		AC four-terminal method	AC four-terminal method	AC four-terminal method	AC four-terminal method
Measurement frequency		1 kHz ±0.2 Hz			
Rated input voltage		±22 V DC	±60 V DC	±100 V DC	±300 V DC
Maximum rated voltage to	earth	±60 V DC	±60 V DC	±100 V DC	±300 V DC
	3 mΩ	N/A	N/A	3.1000 mΩ, 0.1 μΩ, 100 mA	3.1000 mΩ, 0.1 μΩ, 100 mA
Resistance measurement	30 mΩ	N/A	31.000 mΩ, 1 μΩ, 100 mA	31.000 mΩ, 1 μΩ, 100 mA	31.000 mΩ, 1 μΩ, 100 mA
ranges	300 mΩ	310.00 mΩ,10 μΩ, 10 mA			
Mar allocate	<u>3Ω</u>	3.1000 Ω,100 μΩ, 1 mA			
Max. display, resolution,	30 Ω 300 Ω	N/A	31.000 Ω, 1 mΩ, 100 μA	31.000 Ω, 1 mΩ, 100 μA	31.000 Ω, 1 mΩ, 100 μA
measurement	300 Ω 3 kΩ	N/A	310.00 Ω, 10 mΩ, 10 μA	310.00 Ω, 10 mΩ, 10 μA	310.00 Ω, 10 mΩ, 10 μA
s Max. display, resolution, measurement current	3 mO	N/A N/A	3.1000 kΩ, 100 mΩ, 10 μA N/A	3.1000 kΩ, 100 mΩ, 10 μA ±0.5% rdg ±10 dgt	3.1000 kΩ, 100 mΩ, 10 μA ±0.5% rdg ±10 dqt
	v 30 mO	±0.5% rdg ±5 dgt			
Voltage measurement	6 V	N/A	6.000 00 V,10 μV	6.000 00 V,10 μV	6.000 00 V, 10 μV
Voltage	20 V	19.999 9 V, 100 µV	N/A	N/A	N/A
measurement	60 V	N/A	60.000 0 V, 100 μV	60.000 0 V, 100 μV	60.000 0 V, 100 μV
ranges	100 V	N/A	N/A	100.000 V, 1 mV	N/A
Max. display,	300 V	N/A	N/A	N/A	300.000 V, 1 mV
resolution	1000 V	N/A	N/A	N/A	N/A
Basic ad	ccuracy	±0.01% rdg ±3 dgt			
Response time *1		3 ms	10 ms	10 ms	10 ms
Sampling period <sup>'2</sup> EX.FAST, FAST, MEDIUM, SLO	Ω or V W ΩV	4 ms, 12 ms, 35 ms, 150 ms 7 ms, 23 ms, 69 ms, 252 ms	4 ms, 12 ms, 35 ms, 150 ms 8 ms, 24 ms, 70 ms, 253 ms	4 ms, 12 ms, 35 ms, 150 ms 8 ms, 24 ms, 70 ms, 253 ms	4 ms, 12 ms, 35 ms, 150 ms 8 ms, 24 ms, 70 ms, 253 ms
Allowable total line resistance	<sup>11</sup> SENSE line	Ν/Α, Ν/Α, 20 Ω, 20 Ω	Ν/Α, 6.5 Ω, 30 Ω, 30 Ω	6.5 Ω, 6.5 Ω, 30 Ω, 30 Ω	6.5 Ω, 6.5 Ω, 30 Ω, 30 Ω
(error detection) Ranges: 3 m $\Omega$ , 30 m $\Omega$ , 300 m $\Omega$ , 3		Ν/Α, Ν/Α, 50 Ω, 500 Ω	Ν/Α, 5.5 Ω, 15 Ω, 150 Ω	5.5 Ω, 5.5 Ω, 15 Ω, 150 Ω	5.5 Ω, 5.5 Ω, 15 Ω, 150 Ω
Open terminal voltage Ranges: 30 mΩ or less, 300 mΩ	Ω, 3 Ω or more	N/A, 7 V, 7 V peak	25 V, 7 V, 4 V peak	25 V, 7 V, 4 V peak	25 V, 7 V, 4 V peak
LAN (TCP/IP, 10BASE-	T/100BASE-TX)	N/A	YES	YES	YES
RS-232C *4 (Max. 38400	) bps)	YES	YES	YES	YES
USB GP-IB		N/A	N/A	N/A	N/A
률 GP-IB		YES (3561-01 Only)	N/A	N/A	N/A
EXT I/O (37-pin Handle	,	YES (36-pin)	YES	YES	YES
Analog output (DC 0 V	to 3.1 V)	N/A	YES	YES	YES
Contact check	) ocumta'	YES	YES	YES	YES
Zero adjustment (±1000 Measurement current p	,	YES N/A	YES	YES	YES
Comparator		Hi/ IN/ Lo	Hi/ IN/ Lo	Hi/ IN/ Lo	Hi/ IN/ Lo
		Max. 30,000	Max. 30,000	Max. 30,000	Max. 30,000
Statistical calculations Delay		YES	YES	YES	YES
Average		2 to 16 times			
Panel saving/loading		126	126	126	126
Memory storage		400	400	400	400
LabVIEW <sup>®</sup> driver *5		YES	YES	YES	YES
Applicable standards		Safety: EN61010 EMC: EN61326 Class A			
Effect of radiated radio-free electromagnetic field	quency	Resistant "6	Resistant '6	Resistant *6	Resistant *6
Effect of conducted radiofrequency	10 V	N/A	Resistant	Resistant	Resistant
electromagnetic field	3 V	Resistant	Resistant	Resistant	Resistant
CE		YES	YES	YES	YES
CSA *7		N/A	YES	YES	YES
Dimensions • Weight		215W × 80H × 295D mm (8.46W × 3.15H × 11.61D in) 2.4 kg (84.66 oz)	215W × 80H × 295D mm (8.46W × 3.15H × 11.61D in) 2.4 kg (84.66 oz)	215W × 80H × 295D mm (8.46W × 3.15H × 11.61D in) 2.4 kg (84.66 oz)	215W × 80H × 295D mm (8.46W × 3.15H × 11.61D in) 2.4 kg (84.66 oz)

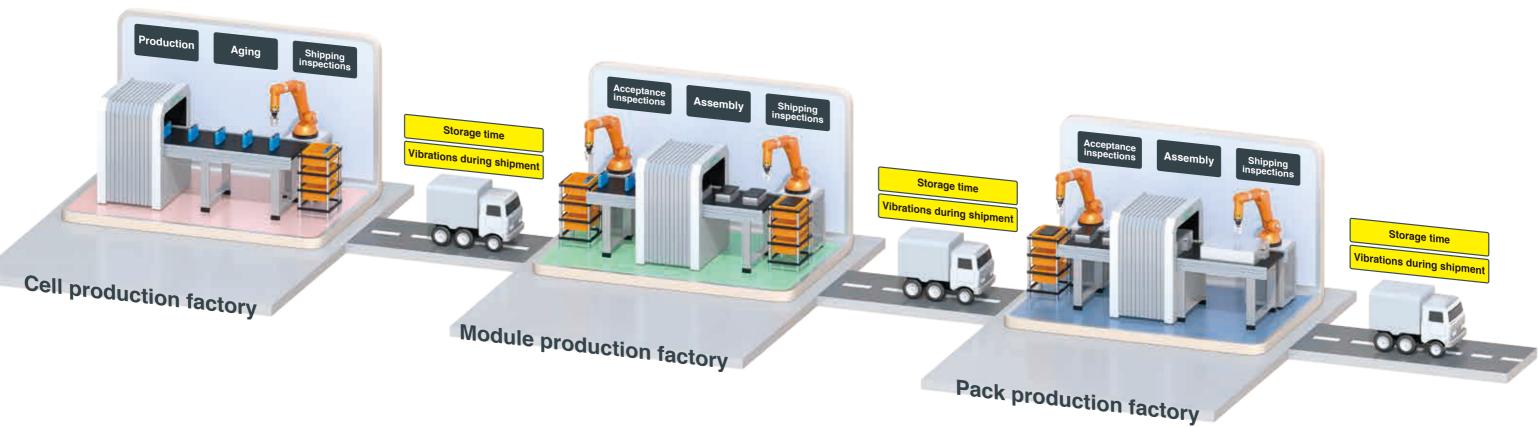
\*1: Typical value \*2: When the power supply frequency is 60 Hz \*3: Total line resistance = wiring resistance + contact resistance + DUT resistance \*4: Available as printer I/F \*5: LabVIEW® Driver is a registered trademark of National Instruments Corporation \*6: Test conditions were 80 MHz to 1 GHz at 10 V/m and 1 GHz to 6 GHz at 3 V/m, all at 80% AM \*7: Canadian Standards Assosiation

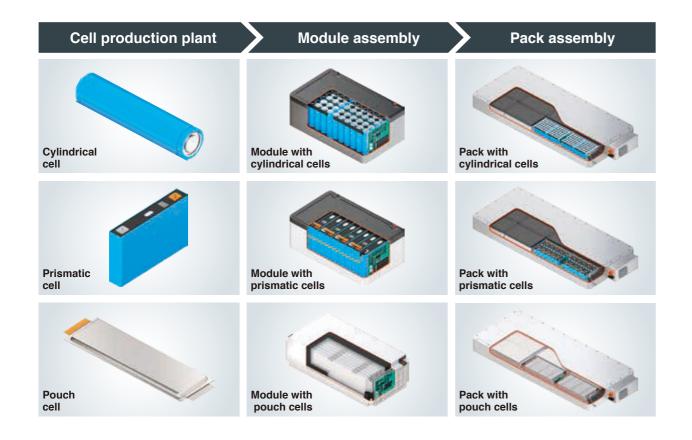
			Acceptance/ship	ping inspections	R & D	Maintenance	
Application			Extra large packs for xEV, ESS 1000 V high voltage model	GP-IB model	Cells or packs up to 20 V Degree of deterioration for reuse	Large-scale UPS	
Model			BT3564	BT3562-01 BT3563-01	BT4560	BT3554-50 <sup>*10</sup> BT3554-51 <sup>*10</sup> BT3554-52 <sup>*10</sup>	
			Special specifications for FCs available		Special specifications for 10 kHz available	NEW	
Appearance					(Refer to P.19)		
Measurement meth	od		AC four-terminal method	AC four-terminal method	AC four-terminal pair method	AC four-terminal method	
Measurement frequ	lency		1 kHz ±0.2 Hz	1 kHz ±0.2 Hz	0.10 Hz to 1050 Hz	1 kHz ±80 Hz	
Rated input voltage	ŧ		±1000 V DC	BT3562-01: ±70 V DC BT3563-01: ±300 V DC	±5 V DC Special specification supports up to ±20 V DC	±60 V DC	
Maximum rated vol	tage to eart	h	±1000 V DC	BT3562-01: ±60 V DC BT3563-01: ±300 V DC	SOURCE-H, SENSE-H: ±5 V DC SOURCE-L, SENSE-L: 0 V DC	±60 V DC	
		3 mΩ	3.1000 mΩ, 0.1 μΩ, 100 mA	3.1000 mΩ, 0.1 μΩ, 100 mA	Resistance (R)		
Resistance		30 mΩ	31.000 mΩ, 1 μΩ, 100 mA	31.000 mΩ, 1 μΩ, 100 mA	3.6000 mΩ, 0.1 μΩ, 1.5 A 12.0000 mΩ, 0.1 μΩ, 500 mA	Resistance (R)	
measurement ranges		300 mΩ	310.00 mΩ,10 $\mu\Omega,$ 10 mA	310.00 mΩ,10 μΩ, 10 mA	120.000 mΩ, 1 μΩ, 50 mA	3.100 mΩ, 1 μΩ, 160 mA 31.00 mΩ, 10 μΩ, 160 mA	
		3Ω	3.1000 Ω,100 μΩ, 1 mA	3.1000 Ω,100 μΩ, 1 mA	[The number of waveforms] Frequency: FAST, MEDIUM, SLOW	31.00 mΩ, 10 μΩ, 160 mA 310.0 mΩ, 100 μΩ, 16 mA	
Max. display,		30 Ω	31.000 Ω, 1 mΩ, 100 μΑ	31.000 Ω, 1 mΩ, 100 μA	0.10 Hz to 66 Hz: 1 wave, 2 waves, 8 waves	3.100 Ω, 1 mΩ, 1.6 mA	
resolution, measurement		300 Ω	310.00 Ω, 10 mΩ, 10 μΑ	310.00 Ω, 10 mΩ, 10 μΑ	67 Hz to 250 Hz: 2 waves, 8 waves, 32 waves 260 Hz to 1050 Hz: 8 waves, 32 waves, 128 waves	[Basic accuracy] ±1.0% rdg ±8 dgt	
current _		3 kΩ	3.1000 kΩ, 100 mΩ, 10 μA	3.1000 kΩ, 100 mΩ, 10 μA	Reactance (X)	(3 mΩ range)	
	Basic	3 mΩ range	±0.5% rdg ±10 dgt "8	±0.5% rdg ±10 dgt	±3.6000 mΩ, $0.1 \mu$ Ω, $1.5 A$	±0.8% rdg ±6 dgt (30 mΩ range or more)	
voltage	accuracy	30 mΩ range or more	±0.5% rdg ±5 dgt '8	±0.5% rdg ±5 dgt	$\pm 120.000$ mΩ, 1 μΩ, 50 mA	,	
9 ng		6 V	N/A	6.000 00 V, 10 μV	<b>Impedance (Ζ)</b> 3.6000 mΩ, 0.1 μΩ, 1.5 A	Voltage (V) 6.000 V, 1 mV	
Voltage measurement		10 V	9.999 99 V, 10 μV	N/A	12.0000 mΩ, 0.1 μΩ, 500 mA	60.00 V, 10 mV	
ranges		60 V 100 V	N/A 99.999 9 V, 100 μV	60.000 0 V, 100 μV N/A	120.000 mΩ, 1 μΩ, 50 mA Phase angle (θ)	[Basic accuracy] ±0.08% rdg ±6 dgt	
Max. display,		300 V	Ν/Α	300.000 V, 1 mV (BT3563-01 only)	±180.000°, 0.001°	Tomporature (°C)	
resolution		1000 V	1100.00 V, 1 mV '9	N/A	[Basic accuracy] Refer to P.19 Voltage (V)	Temperature (°C) -10.0°C to 60.0°C, 0.1°C	
-	Basic accur		±0.01% rdg ±3 dgt "8	±0.01% rdg ±3 dgt	±5.10000 Ϋ, 10 μV		
Response time *1			700 ms	10 ms	[Basic accuracy] ±0.0035% rdg ±5 dgt [Sampling period]	1.6 s	
Sampling period "2		Ω or V	N/A, 12 ms, 35 ms, 253 ms	4 ms, 12 ms, 35 ms, 150 ms	FAST, MEDIUM, SLOW	N/A	
EX.FAST, FAST, MEDI	UM, SLOW	ΩV	N/A, 28 ms, 74 ms, 359 ms	8 ms, 24 ms, 70 ms, 253 ms	0.1 s, 0.4 s, 1.0 s Temperature (°C)	100 ms	
Allowable total line re	sistance "1 "3	SENSE line	3 Ω, 3 Ω, 20 Ω, 20 Ω	2 Ω, 2 Ω, 15 Ω, 15 Ω	-10.0°C to 60.0°C, 0.1°C Allowable total line resistance 1''	N/A	
(error detection) Ranges: 3 mΩ, 30 mΩ, 3	00 mΩ, 3 Ω	SOURCE line	3 Ω, 3 Ω, 20 Ω, 200 Ω	2 Ω, 2 Ω, 15 Ω, 150 Ω	(error detection) $3 \text{ m}\Omega$ , 10 m $\Omega$ , 100 m $\Omega$	N/A	
Open terminal volta Ranges: 30 mΩ or less	•	Ω or more	25 V, 7 V, 4 V peak	25 V, 7 V, 4 V peak	SENSE line: 10 Ω, 15 Ω, 50 Ω SOURCE line: 1.5 Ω, 4 Ω, 45 Ω	5 V max	
LAN (TCP/IP, 10	BASE-T/10	00BASE-TX)	N/A	N/A	N/A	• LISB	
RS-232C *4 (Max	x 38100 hr	LAN (TCP/IP, 10BASE-T/100BASE-TX)				• USB	
e 110 2020 (Ma	~. 00400 bp	s)	YES	YES	YES	Wireless communication	
USB		s)	N/A	N/A	YES		
USB GP-IB		-	N/A YES	N/A YES	YES N/A	Wireless communication	
USB GP-IB EXT I/O (37-pin	Handler int	erface)	N/A YES YES	N/A YES YES	YES N/A YES	Wireless communication: (*when Z3210 installed)     Memory function (Up to 6000 data)	
USB GP-IB EXT I/O (37-pin Analog output (	Handler int	erface)	N/A YES YES YES	N/A YES YES YES	YES N/A YES N/A	Wireless communication: (*when Z3210 installed)     Memory function (Up to 6000 data)     Auto memory function     Auto-hold function	
USB GP-IB EXT I/O (37-pin Analog output ( Contact check	Handler int	erface) 3.1 V)	N/A YES YES YES YES	N/A YES YES YES YES	YES N/A YES N/A YES	Wireless communications (*when Z3210 installed)     Memory function (Up to 6000 data)     Auto memory function     Auto-hold function     Measurement Navigator	
USB GP-IB EXT I/O (37-pin Analog output ( Contact check Zero adjustmen	Handler interest (DC 0 V to 3 t (±1000 con	erface) 3.1 V) unts)	N/A YES YES YES YES YES	N/A YES YES YES YES YES	YES N/A YES N/A YES YES''1	Wireless communication: (*when Z3210 installed)     Memory function (Up to 6000 data)     Auto memory function     Auto-hold function     Measurement Navigator (When using Z3210, GENNECT Cross	
USB GP-IB EXT I/O (37-pin Analog output ( Contact check Zero adjustmen Measurement c	Handler interest (DC 0 V to 3 t (±1000 con	erface) 3.1 V) unts)	N/A YES YES YES YES YES YES	N/A YES YES YES YES YES YES	YES N/A YES N/A YES YES' <sup>11</sup> YES	Wireless communication: (*when Z3210 installed)     Memory function (Up to 6000 data)     Auto memory function     Auto-hold function     Measurement Navigator (When using Z3210, GENNECT Cross : Voice guide output)	
USB GP-IB EXT I/O (37-pin Analog output ( Contact check Zero adjustmen	Handler int (DC 0 V to 3 t (±1000 con urrent pulse	erface) 3.1 V) unts)	N/A YES YES YES YES YES Hi/ IN/ Lo	N/A YES YES YES YES YES Hi/ IN/ Lo	YES N/A YES N/A YES YES''1	Wireless communications (*when Z3210 installed)     Memory function (Up to 6000 data)     Auto memory function     Auto-hold function     Measurement Navigator (When using Z3210, GENNECT Cross     : Voice guide output)     Auto power-off     Tablet app	
USB GP-IB EXT I/O (37-pin Analog output ( Contact check Zero adjustmen Measurement c Comparator	Handler int (DC 0 V to 3 t (±1000 con urrent pulse	erface) 3.1 V) unts)	N/A YES YES YES YES YES YES	N/A YES YES YES YES YES YES	YES N/A YES N/A YES YES''' YES Hi/ IN/ Lo	Wireless communication: (*when Z3210 installed)     Memory function (Up to 6000 data)     Auto memory function     Auto-hold function     Measurement Navigator (When using Z3210, GENNECT Cross     : Voice guide output)     Auto power-off     Tablet app (GENNECT Cross)	
USB GP-IB EXT I/O (37-pin Analog output ( Contact check Zero adjustmen Measurement c Comparator Statistical calcul	Handler int (DC 0 V to 3 t (±1000 con urrent pulse	erface) 3.1 V) unts)	N/A YES YES YES YES YES Hi/ IN/ Lo Max. 30,000	N/A YES YES YES YES YES Hi/ IN/ Lo Max. 30,000	YES N/A YES N/A YES YES''' YES Hi/ IN/ Lo N/A	Wireless communication: (*when Z3210 installed)     Memory function (Up to 6000 data)     Auto memory function Auto-hold function Measurement Navigator (When using Z3210, GENNECT Cross : Voice guide output)     Auto power-off Tablet app (GENNECT Cross) PC app (GENNECT One)	
USB GP-IB EXT I/O (37-pin Analog output ( Contact check Zero adjustmen Measurement c Comparator Statistical calcul Delay	Handler inti (DC 0 V to 3 t (±1000 cou urrent pulse lations	erface) 3.1 V) unts)	N/A YES YES YES YES YES Hi/ IN/ Lo Max. 30,000 YES	N/A YES YES YES YES YES Hi/ IN/ Lo Max. 30,000 YES	YES N/A YES N/A YES YES''' YES Hi/ IN/ Lo N/A YES	Wireless communications (*when Z3210 installed)     Memory function (Up to 6000 data)     Auto memory function     Auto-hold function     Measurement Navigator (When using Z3210, GENNECT Cross     : Voice guide output)     Auto power-off     Tablet app (GENNECT Cross)     PC app (GENNECT One)     Comparator function	
USB GP-IB EXT I/O (37-pin Analog output ( Contact check Zero adjustmen Measurement c Comparator Statistical calcul Delay Average	Handler int (DC 0 V to 3 t (±1000 con urrent pulse lations	erface) 3.1 V) unts)	N/A YES YES YES YES YES Hii/ IN/ Lo Max. 30,000 YES 2 to 16 times	N/A YES YES YES YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times	YES           N/A           YES           N/A           YES           YES'''           YES'''           YES           Hi/ IN/ Lo           N/A           YES           1 to 99 times	Wireless communications (*when Z3210 installed)     Memory function (Up to 6000 data)     Auto memory function     Auto-hold function     Measurement Navigator (When using Z3210, GENNECT Cross     : Voice guide output)     Auto power-off     Tablet app (GENNECT Cross)     PC app (GENNECT Cross)     PC app (GENNECT One)     Comparator function (PASS/ WARNING/ FAIL)     Excel® Direct Input function	
USB GP-IB EXT I/O (37-pin Analog output ( Contact check Zero adjustmen Measurement ci Comparator Statistical calcul Delay Average Panel saving/loc	Handler int (DC 0 V to 3 t (±1000 con urrent pulse lations ading	erface) 3.1 V) unts)	N/A YES YES YES YES YES Hii/ IN/ Lo Max. 30,000 YES 2 to 16 times 126	N/A YES YES YES YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times 126	YES N/A YES N/A YES YES'''' YES Hi/ IN/ Lo N/A YES 1 to 99 times 126	Wireless communications (*when Z3210 installed)     Memory function (Up to 6000 data)     Auto memory function     Auto-hold function     Measurement Navigator (When using Z3210, GENNECT Cross     : Voice guide output)     Auto power-off     Tablet app (GENNECT Cross)     PC app (GENNECT Cross)     PC app (GENNECT Ore)     Comparator function (PASS/ WARNING/ FAIL)	
USB GP-IB EXT I/O (37-pin Analog output ( Contact check Zero adjustmen Measurement c Comparator Statistical calcul Delay Average Panel saving/loa Memory storage LabVIEW® drive	Handler int (DC 0 V to 3 t (±1000 con urrent pulse lations ading e er <sup>15</sup>	erface) 3.1 V) unts)	N/A           YES           YES           YES           YES           YES           Hi/ IN/ Lo           Max. 30,000           YES           2 to 16 times           126           400	N/A           YES           YES           YES           YES           YES           Hi/ IN/ Lo           Max. 30,000           YES           2 to 16 times           126           400	YES N/A YES N/A YES YES''' YES Hi/ IN/ Lo N/A YES 1 to 99 times 126 N/A	Wireless communication: (*when Z3210 installed)     Memory function (Up to 6000 data)     Auto memory function     Auto-hold function     Measurement Navigator (When using Z3210, GENNECT Cross     : Voice guide output)     Auto power-off     Tablet app (GENNECT Cross)     PC app (GENNECT Cross)     PC app (GENNECT Cross)     PC app (GENNECT Cros)     Comparator function (PASS/ WARNING/ FAIL)     Excel® Direct Input functi (When using Z3210)     Safety: EN61010	
USB GP-IB EXT I/O (37-pin Analog output ( Contact check Zero adjustmen Measurement c Comparator Statistical calcul Delay Average Panel saving/loa Memory storage LabVIEW® drive	Handler int (DC 0 V to 3 t (±1000 con urrent pulse lations ading er <sup>r5</sup> ds adio-frequen	erface) 3.1 V) unts) e output	N/A           YES           YES           YES           YES           YES           Hi/ IN/ Lo           Max. 30,000           YES           2 to 16 times           126           400           N/A           Safety: EN61010	N/A           YES           YES           YES           YES           YES           Hi/ IN/ Lo           Max. 30,000           YES           2 to 16 times           126           400           YES           Safety: EN61010	YES           N/A           YES           N/A           YES           YES           Hi/ IN/ Lo           N/A           YES           1 to 99 times           126           N/A           YES           Safety: EN61010	Wireless communication: (*when Z3210 installed)     Memory function (Up to 6000 data)     Auto memory function     Auto-hold function     Measurement Navigator (When using Z3210, GENNECT Cross     : Voice guide output)     Auto power-off     Tablet app (GENNECT Cross)     PC app (GENNECT Cross)     PC app (GENNECT Cross)     PC app (GENNECT Cros)     Comparator function (PASS/ WARNING/ FAIL)     Excel® Direct Input functi (When using Z3210)     Safety: EN61010	
USB GP-IB EXT I/O (37-pin Analog output ( Contact check Zero adjustmen Measurement c Comparator Statistical calcul Delay Average Panel saving/loa Memory storage LabVIEW® drive Applicable standard	Handler int (DC 0 V to 3 t (±1000 cou urrent pulse lations ading e er <sup>r5</sup> ds adio-frequent Id	erface) 3.1 V) unts) e output	N/A           YES           2 to 16 times           126           400           N/A           Safety: EN61010           EMC: EN61326 Class A	N/A           YES           2 to 16 times           126           400           YES           Safety: EN61010           EMC: EN61326 Class A	YES N/A YES N/A YES YES' <sup>11</sup> YES Hi/ IN/ Lo N/A YES 1 to 99 times 126 N/A YES Safety: EN61010 EMC: EN61326 Class A	Wireless communications (*when Z3210 installed)     Memory function (Up to 6000 data)     Auto memory function Auto-hold function Measurement Navigator (When using Z3210, GENNECT Cross : Voice guide output)     Auto power-off Tablet app (GENNECT Cross) PC app (GENNECT One) Comparator function (PASS/ WARNING/ FAIL) Excel <sup>®</sup> Direct Input function (When using Z3210)     Safety: EN61010 EMC: EN61326 Class E	
USB GP-IB EXT I/O (37-pin Analog output ( Contact check Zero adjustmen Measurement c Comparator Statistical calcul Delay Average Panel saving/loc Memory storage	Handler int (DC 0 V to 3 t (±1000 cou urrent pulse lations ading e er <sup>r5</sup> ds adio-frequent Id	erface) 3.1 V) unts) e output	N/A YES YES YES YES YES Hii/ IN/ Lo Max. 30,000 YES 2 to 16 times 126 400 N/A Safety: EN61010 EMC: EN61326 Class A Resistant '8	N/A YES YES YES YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times 126 400 YES Safety: EN61010 EMC: EN61326 Class A Resistant '8	YES N/A YES N/A YES YES' <sup>11</sup> YES Hi/ IN/ Lo N/A YES 1 to 99 times 126 N/A YES Safety: EN61010 EMC: EN61326 Class A Resistant '8	Wireless communications (*when Z3210 installed)     Memory function (Up to 6000 data)     Auto memory function     Auto-hold function     Measurement Navigator (When using Z3210, GENNECT Cross     : Voice guide output)     Auto power-off     Tablet app (GENNECT Cross)     PC app (GENNECT One)     Comparator function (PASS/ WARNING/ FAIL) Excel® Direct Input functii (When using Z3210)     Safety: EN61010 EMC: EN61326 Class E Resistant (3 V/m)	
USB GP-IB EXT I/O (37-pin Analog output ( Contact check Zero adjustmen Measurement c Comparator Statistical calcul Delay Average Panel saving/loa Memory storage LabVIEW® drive Applicable standard Effect of radiated re electromagnetic fiel	Handler int (DC 0 V to 3 t (±1000 cou urrent pulse lations ading e er <sup>r5</sup> ds adio-frequent Id	terface) 3.1 V) unts) e output ncy 10 V	N/A YES YES YES YES YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times 126 400 N/A Safety: EN61010 EMC: EN61326 Class A Resistant <sup>'8</sup> N/A	N/A YES YES YES YES YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times 126 400 YES Safety: EN61010 EMC: EN61326 Class A Resistant <sup>18</sup> N/A	YES N/A YES N/A YES'11 YES'11 YES Hi/ IN/ Lo N/A YES 1 to 99 times 126 N/A YES Safety: EN61010 EMC: EN61326 Class A Resistant '8 N/A	Wireless communications (*when Z3210 installed)     Memory function (Up to 6000 data)     Auto memory function Auto-hold function Measurement Navigator (When using Z3210, GENNECT Cross : Voice guide output)     Auto power-off Tablet app (GENNECT Cross) PC app (GENNECT One) Comparator function (PASS/ WARNING/ FAIL) Excel® Direct Input functio (When using Z3210) Safety: EN61010 EMC: EN61326 Class E Resistant (3 V/m) N/A	
USB GP-IB EXT I/O (37-pin Analog output ( Contact check Zero adjustmen Measurement c Comparator Statistical calcul Delay Average Panel saving/loa Memory storage LabVIEW® drive Applicable standard Effect of radiated ra electromagnetic fiel	Handler int (DC 0 V to 3 t (±1000 cou urrent pulse lations ading e er <sup>r5</sup> ds adio-frequent Id	terface) 3.1 V) unts) e output ncy 10 V	N/A YES YES YES YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times 126 400 N/A Safety: EN61010 EMC: EN61326 Class A Resistant <sup>*6</sup> N/A Resistant	N/A YES YES YES YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times 126 400 YES Safety: EN61010 EMC: EN61326 Class A Resistant <sup>16</sup> N/A Resistant	YES N/A YES N/A YES YES'11 YES Hi/ IN/ Lo N/A YES 1 to 99 times 126 N/A YES Safety: EN61010 EMC: EN61326 Class A Resistant <sup>16</sup> N/A Resistant	Wireless communications (*when Z3210 installed)     Memory function (Up to 6000 data)     Auto memory function     Auto-hold function     Measurement Navigator (When using Z3210, GENNECT Cross     : Voice guide output)     Auto power-off     Tablet app (GENNECT Cross)     PC app (GENNECT Cross)     PC app (GENNECT Cross)     PC app (GENNECT Cros)     PC app (GENNECT One)     Comparator function (PASS/ WARNING/ FAIL)     Excel® Direct Input functi (When using Z3210)     Safety: EN61010 EMC: EN61326 Class E Resistant (3 V/m)     N/A     N/A	

\*8: Average function: When set to ON 4 times \*9: Resolution 10 mV for 1000.00 V or more \*10: -50: Instrument only, -51: 9465-10 bundle, -52: L2020 bundle \*11: Zero-adjustment range R: ±0.1000 mΩ (3 mΩ range), ±0.3000 mΩ (10 mΩ range), ±3.000 mΩ (100 mΩ range), X: ±1.5000 mΩ (Common for all ranges), V: ±0.10000 V

6

## Measuring battery performance and safety





## Measuring battery performance and safety using internal resistance (AC-IR) and open-circuit voltage (OCV)

Testing plays an important role in production processes by allowing plants to manufacture safe, high-performance batteries. During shipping and acceptance inspections, technicians assess battery performance by measuring internal resistance and safety by measuring open-circuit voltage.

Our Battery testers meet these needs...

"We want to manufacture batteries with stable performance."

"We want to manufacture highly safe batteries."

### Assembly process (from cell batteries to pack batteries)

Cells produced at the cell production factory are shipped to the module production factory after undergoing a shipping inspection. Since factors such as vibrations during shipment and even the passage of time can cause defects, batteries undergo an acceptance inspection before being assembled into modules and packs.

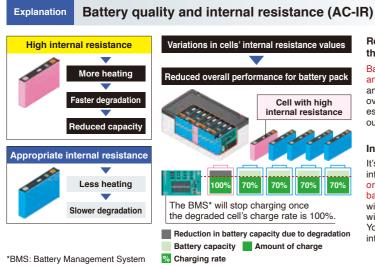




3561, 3561-01, BT3561A, BT3562A, BT3563A, BT3564, BT3562-01, BT3563-01, BT4560

#### Measuring battery performance and safety

### Manufacturing batteries with stable performance



#### Relationship between the internal resistance and the decline of battery cell capacity

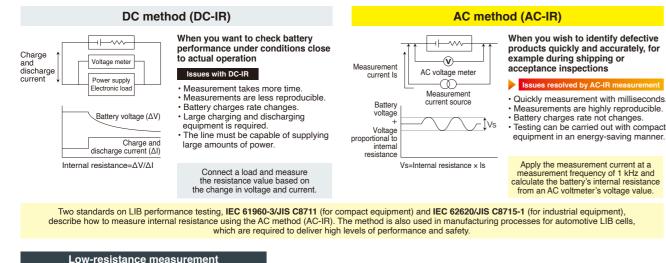
Battery cells with high internal resistance tend to generate more heat and degrade faster. When cells degrade, their capacity declines, and their internal resistance rises. Internal resistance also changes over time or as a consequence of vibrations during shipment. It's essential to eliminate cells with high internal resistance by carrying out an inspection each time cells are shipped or received.

#### Internal resistance and battery pack performance

It's important that all the cells in a given battery pack have uniform internal resistance. If one or more cells have high internal resistance or have degraded, they will become a bottleneck and limit the battery pack's capacity. Moreover, the battery pack's performance will rapidly decline as the BMS\* attempts to protect degraded cells with reduced capacity from overcharging and over-discharging. You can improve battery cell quality by selecting cells with uniform internal resistance so that they will degrade uniformity.

#### 3561, 3561-01, BT3561A, BT3562A, BT3563A, BT3564, BT3562-01, BT3563-01, BT4560

There are two methods for measuring a battery's internal resistance: the AC method and the DC method. Resistance values are known as AC-IR when measured using the AC method, and as DC-IR when measured using the DC method. AC-IR and DC-IR have a complementary relationship, and it's recommended to choose the one that best suits your application, or to carry out both measurements. HIOKI battery testers can perform 4-terminal AC-IR measurement.

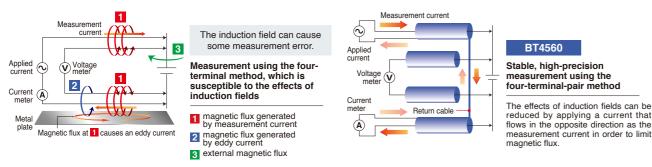


### $(1 m\Omega and lower)$ for large batteries

Internal resistance measurement (AC-IR measurement)

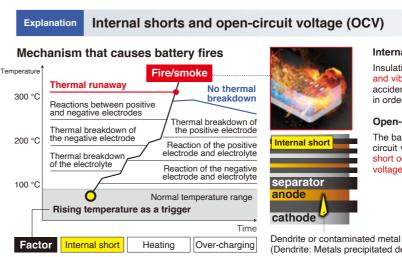
BT4560

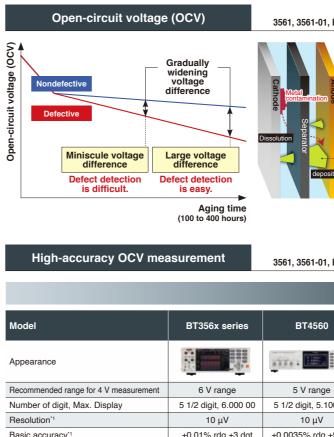
The larger the battery, the lower its internal resistance. Large batteries used in automobiles and infrastructure applications sometimes have internal resistance values of less than 1 mΩ. The BT4560's four-terminal-pair measurement method, which reduces the effects of induction fields, is an optimal solution for accurately measuring such low resistance levels.



### Measuring battery performance and safety

### Manufacturing highly safe batteries





Basic accuracy <sup>1</sup>	±0.01% rdg ±3 dgt	±0.0035% rdg ±		
Measurement error*1 *2	±430 μV	±190 μV		
Period of accuracy guarantee	1 year	1 year		
Temperature measurement	N/A	YES		
Temperature Compensation Function	Ν/Δ	N/A		

\*1: When using recommended range for 4 V measurement \*2: When measuring a 4 V LIB cell

#### Internal shorts

Insulation defects, which can be caused by factors such as ageing and vibrations during shipment, can lead to fire and other dangerous accidents, making it necessary to check open-circuit voltage values in order to distinguish between defective and non-defective products.

#### Open-circuit voltage (OCV)

The battery voltage when no load is connected is known as the opencircuit voltage (OCV). When an insulation defect such as an internal short occurs inside the battery, self-discharge causes the open-circuit voltage to decrease

(Dendrite: Metals precipitated dendritic form)

#### 3561, 3561-01, BT3561A, BT3562A, BT3563A, BT3564, BT3562-01, BT3563-01, BT4560, DM7276



Since the amount of change in OCV caused by self-discharge is extremely small, it is necessary to age batteries at least 100 to 400 hours before testing can accurately distinguish between non-defective and defective products. Additionally, it is necessary to measure OCV multiple times during the aging process. Using an instrument with good accuracy makes it possible to remove defects from the testing line earlier in the process, significantly reducing management and testing costs.

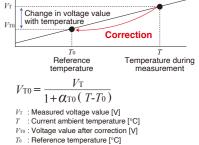
#### Dendrites form over time as minuscule metal fragment contaminants dissolve, leading to internal shorts.

#### 3561, 3561-01, BT3561A, BT3562A, BT3563A, BT3564, BT3562-01, BT3563-01, BT4560, DM7276

High-accuracy							
DM7276 (DC VOLTMETER)							
10 V range							
7 1/2 digit, 12.000 000							
1 µV							
$\pm 0.0009\%$ rdg $\pm 12~\mu V$							
±48 μV							
1 year							
YES							
YES							

#### OCV fluctuates with the ambient temperature

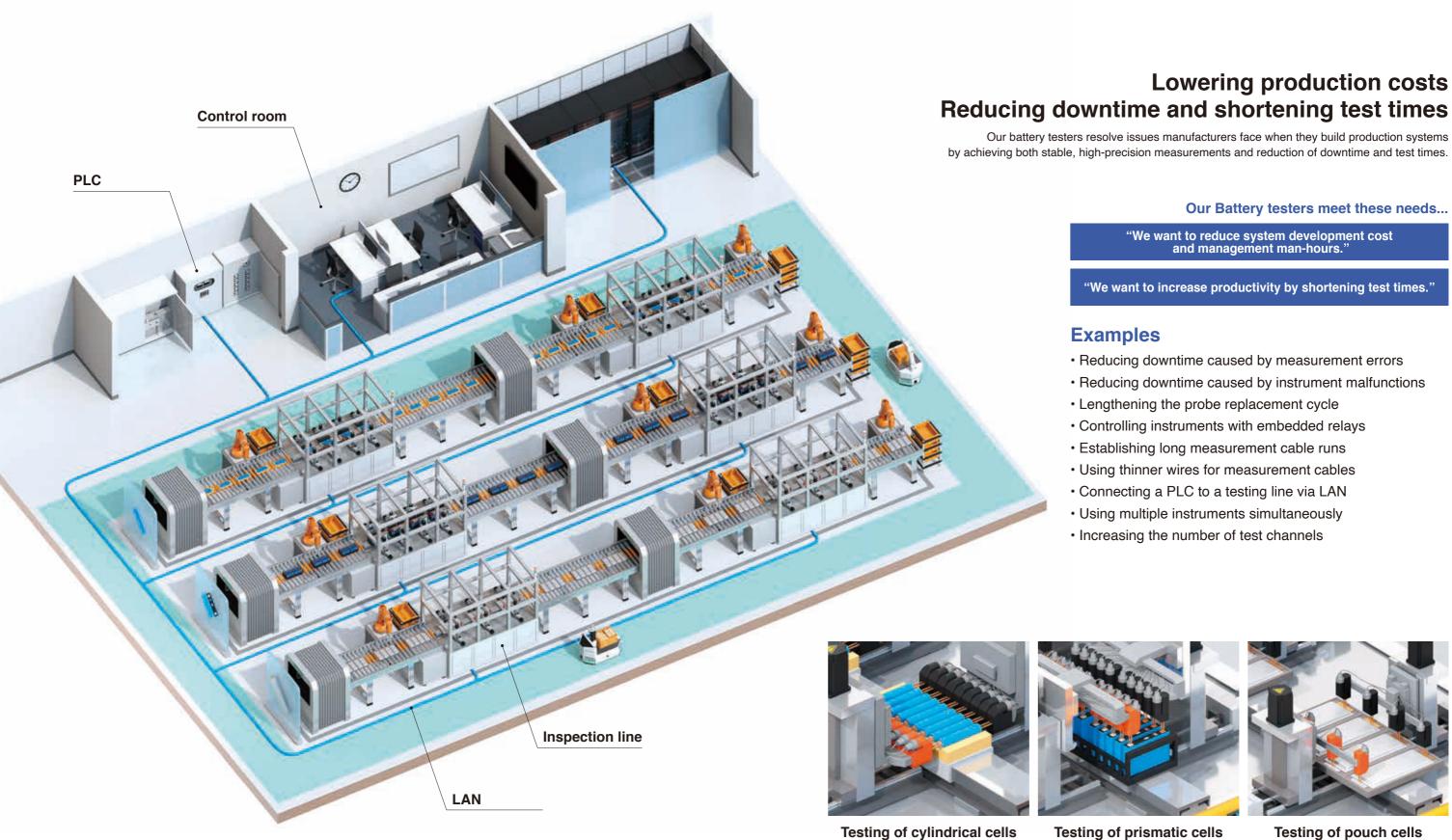
A battery's OCV value can fluctuate several hundred microvolts with a change of just 1°C in the ambient temperature. Temperature correction functionality allows the instrument to display a value that has been converted to the voltage at the reference temperature.



 $\alpha_{\rm T0}$ : Temperature coefficient at  $T_0$  [1/°C]

3561, 3561-01, BT3561A, BT3562A, BT3563A, BT3564, BT3562-01, BT3563-01, BT4560

## Integrate to automatic testing system



Testing of prismatic cells

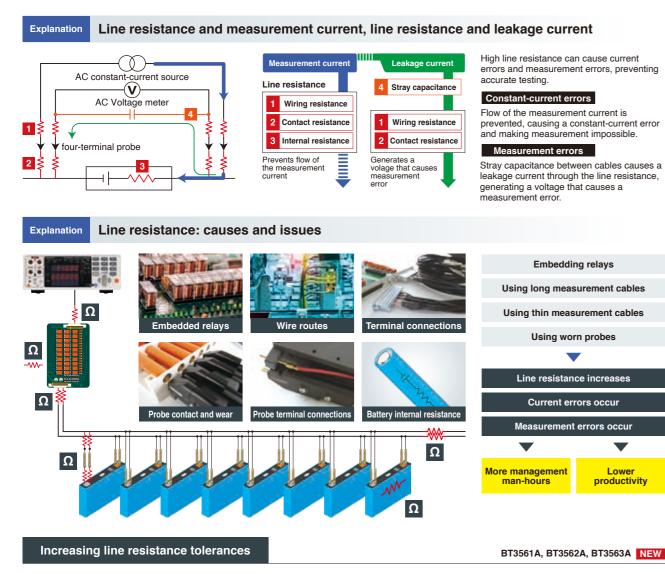
Testing of pouch cells

## Acceptance/shipping inspections

3561, 3561-01, BT3561A, BT3562A, BT3563A, BT3564, BT3562-01, BT3563-01, BT4560

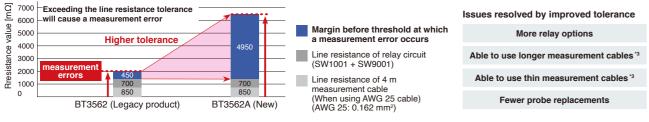
Integrate to automatic testing system

### Reducing test system development cost and management man-hours



The new BT356xA has dramatically improved tolerances for line resistance compared to previous models. This improvement makes it easy to build test systems with large numbers of channels using relays. Additionally, a longer maintenance cycle for systems in use means fewer maintenance man-hours. Finally, its capability to handle thinner cables than with previous models<sup>-3</sup> makes it easier to route cables.

(SENSE side when using 3 m $\Omega$  or 30 m $\Omega$  range)

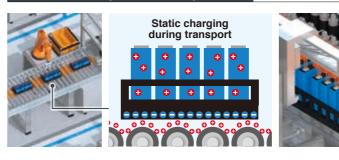


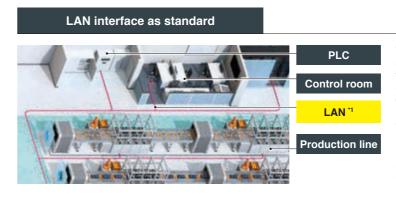
Model			3561, 3	3561-01			BT3	561A		B	T3562A	BT3563	3A	BT3562	2-01, BT3	3563-01,	BT3564
Range		3 mΩ	30 mΩ	300 mΩ	3Ω	3 mΩ	30 mΩ	300 mΩ	3Ω	3 mΩ	30 mΩ	300 mΩ	3Ω	3 mΩ	30 mΩ	300 mΩ	3Ω
Measurement current		N/A	N/A	10 mA	1 mA	N/A	100 mA	10 mA	1 mA	100 mA	100 mA	10 mA	1 mA	100 mA	100 mA	10 mA	1 mA
Allowable total line resistance	SENSE line	N/A	N/A	20 Ω	20 Ω	N/A	6.5 Ω	30 Ω	30 Ω	6.5 Ω	6.5 Ω	30 Ω	30 Ω	2Ω	2 Ω	15 Ω	15 Ω
(error detection) *1 *2	SOURCE line	N/A	N/A	50 Ω	500 Ω	N/A	5.5 Ω	15 Ω	150 Ω	5.5 Ω	5.5 Ω	15 Ω	150 Ω	2Ω	2Ω	15 Ω	150 Ω

\*1: Typical value \*2: Total line resistance = (Wiring resistance + Contact resistance + DUT resistance)

\*3: AWG 29 (0.064 mm<sup>2</sup>) wire equivalent to 2.2  $\Omega$  over an 8 m round trip can be used with the 3 m $\Omega$  or 30 m $\Omega$  range.

#### Preventing instrument malfunctions caused by static electricity

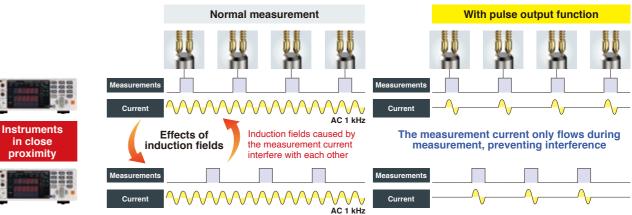






### Using multiple instruments simultaneously

When multiple battery testers are used at the same time, their induction fields can interfere with each other, causing measurement errors. Since the instruments' measurement currents flow continuously, such interference can occur even if measurements are timed so that they don't occur simultaneously. The measurement current pulse output function allows the measurement current to flow only during measurement. By using this function to make alternating measurements, you can avoid the effects of interference between induction fields caused by the measurement current.



#### BT3561A, BT3562A, BT3563A NEW



Batteries can become charged on production lines, for example, when being transported on a conveyor belt. When probes are placed in contact with such batteries, the resulting application of static electricity can then damage the instrument. The BT356xA series is designed to withstand contact with  $\pm 30$  kV of static electricity\*, preventing static-caused malfunctions and reducing testing line downtime.

\* ±30 kV IEC 61000-4-2 contact discharge

#### BT3561A, BT3562A, BT3563A NEW

The BT356xA series is equipped with a LAN interface as standard equipment, making it easy for the instrument to interoperate with a PLC<sup>2</sup>-based control system. The ability to use readily accessible LAN cables helps lower costs during system development and maintenance. Furthermore, a design with strong noise and static electricity resistance helps avoid system problems.

\*1: Max.30 m \*2: Programmable Logic Controller, a device that automatically controls one or more machines

3561, 3561-01, BT3561A, BT3562A, BT3563A, BT3564, BT3562-01, BT3563-01, BT4560

OK

Accurate probing is essential for accurate measurement. Our battery testers are equipped with probe contact monitoring functionality to ensure highly reliable testing.

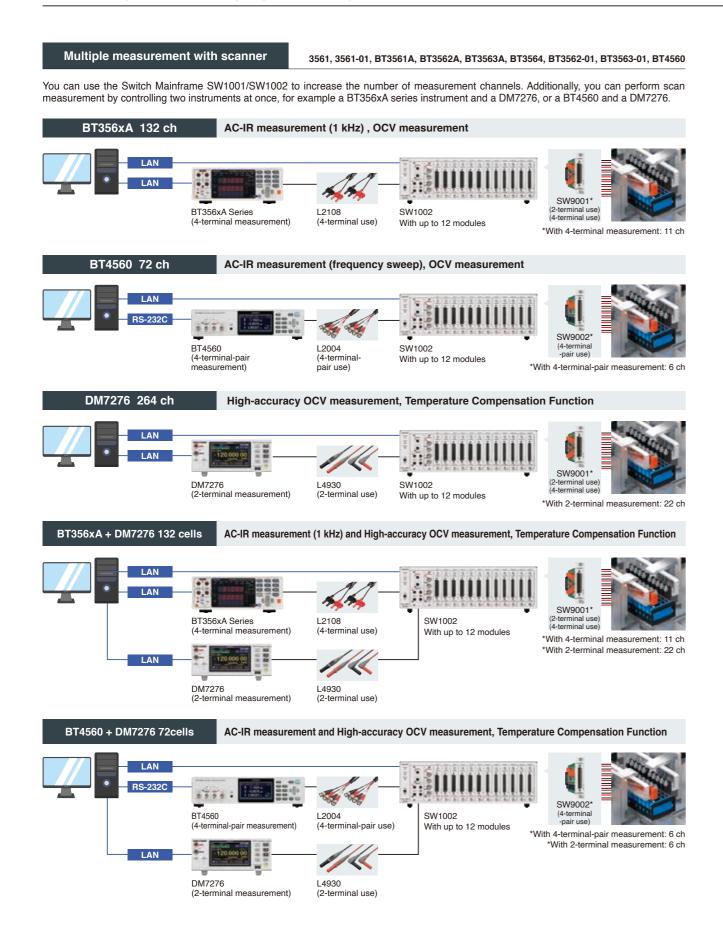
#### BT3561A, BT3562A, BT3563A, BT3564, BT3562-01, BT3563-01, BT4560

14

3561, 3561-01, BT3561A, BT3562A, BT3563A, BT3564, BT3562-01, BT3563-01, BT4560

Integrate to automatic testing system

### Improving productivity by reducing test times



#### Configuration Example of Multi-channel Battery Testing

-			•	-					
Instrument	Number of instruments in use	AC-IR measurement 1 kHz	AC-IR measurement frequency sweep	OCV measurement	High-accuracy OCV measurement Temperature Compensation Function	Connection cable	Switch mainframe	Module	Maximum number of channels
BT356xA	1	YES	N/A	YES	N/A	L2108	SW1002	SW9001	132 ch
BT4560	1	YES	YES	YES	N/A	L2004	SW1002	SW9002	72 ch
DM7276	1	N/A	N/A	N/A	YES	L4930	SW1002	SW9001	264 ch
BT356xA	2	YES	N/A	YES	N/A	L2108	SW1002	014/0004	100 -
DM7276	(switched)	N/A	N/A	N/A	YES	L4930	Switching instrument	SW9001	132 ch
BT4560	2	YES	YES	YES	N/A	L2004	SW1002	014/0000	70 ah
DM7276	(switched)	N/A	N/A	N/A	YES	L4930	Switching instrument	SW9002	72 ch



-

(Interval setting: 1 second to 60 minutes)

SW1002

```
Recording results with 
a dedicated PC application
                                                                              Address and week address
    ----
                    R 131208-000 0 R 131278-000 0
                                       1.31718-003 9
                                                       1.00. 0
 148112-300 9 0 141212-300 9
                                      142315-202 9
 1.200118-000 9 R 1.27518-000 9
                                       127906-001 0
3 999095-009 V
 12101E-000 9 H 1270E-000 9
                                       1 30465-000 Q
```



Cycle time for measurement completion Basic connection 1. Communication time example Start switching channels Finish switching channels Channel switch ng time (11 ms) Cycle time calculation Channel switching time Total time Communication tim

Instrument	Module	Number of channels	Function	Measurement speed	Measu respon
BT3562A	SW9001	11	01/	EX. FAST	10
D13302A	309001	11	ΩV	MEDIUM	10
	6	FAST	01		
BT4560	SW9002	6	RX	MEDIUM	0 1
		22		0.02 PLC*	0 1
DM7276	SW9001	22	V	FAST	0 1
		22	]	MEDIUM	0 1
*Dower Line C	ale 20 me et EC	) H= 16.7 mo of	60 H-		

\*Power Line Cycle 20 ms at 50 Hz, 16.7 ms at 60 Hz





SW9001 SW9002 SW1002: accomodates up to 12 SW9001 or SW9002 modules SW1001: accomodates up to 3 SW9001 or SW9002 modules SW9001 (2-terminal use, 4-terminal use), SW9002 (4-terminal-pair use)

#### 3561, 3561-01, BT3561A, BT3562A, BT3563A, BT3562-01, BT3563-01, BT4560, DM7276



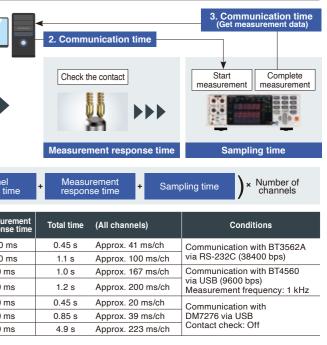
### Logging function

Measure and log up to 264 channels.

**OCV** measurement function Measure OCVs, and additionally record the initial voltages and change rates as well.

Multichannel Nyquist or Cole-Cole plot Measure impedance while varying the frequency across up to 72 channels and display the results as a Nyquist or Cole-Cole plot. \*PC application for SW1001/SW1002.

#### 3561, 3561-01, BT3561A, BT3562A, BT3563A, BT3562-01, BT3563-01, BT4560, DM7276



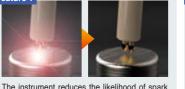
Internal resistance and open-circuit voltage for various battery types and compatible instruments



### **Testing high-voltage** battery packs safely



The BT3564 can safely test high-voltage battery packs such as infrastructure storage batteries.



discharges, which are prone to occur during high-voltage measurement, by limiting the amount of current that flows the instant contact hed with a battery pack

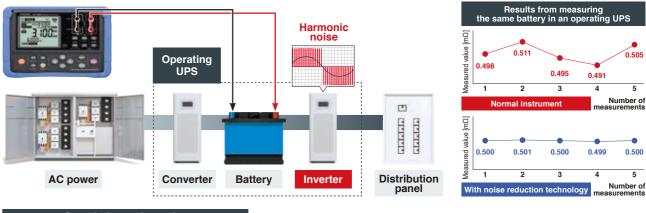


The optional L2110 probe, which is designed specifically for use with the BT3564, can make measurements safely thanks to its 1000 V withstand voltage. Additionally, the probe is designed to accommodate battery packs whose terminals are placed far apart.

## **Diagnosing degradation in batteries**

BT3554-50, BT3554-51, BT3554-52





Completing an intensive inspection workload efficiently

You can efficiently inspect an enormous number of batteries, for example those found in UPS systems, with our free app "GENNECT Cross"



Up to 100 sets of profile information can be registered on the BT3554-5x. Up to 500 data sets can be saved for each profile. (The BT3554-5x can save up to 6,000 data sets.)

To use GENNECT Cross, you must install the Wireless Adapter Z3210 (sold separately) and the GENNECT Cross app on your device. Profile information can be registered on the BT3554-50 from either GENNECT Cross or the desktop application GENNECT ONE.

voltage to determine whether it has degraded

BT3554-50, BT3554-51, BT3554-52

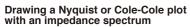
## **Analyzing batteries BT4560**

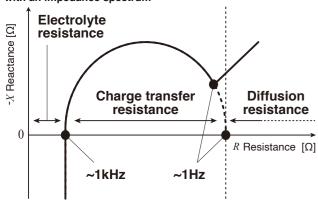


The chemical reactions in batteries involve several processes and each process has its own reaction speed. Therefore by sweeping the

Assessing battery characteristics

frequency and measuring the impedance the characteristics of each part can be evaluated separately.

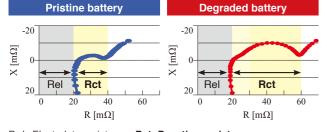




#### Check the battery deterioration level

The resistance of a degraded battery is significantly larger than a pristine one. The degradation of charge transfer resistance is particularly noticeable in the Nyquist or Cole-Cole plot for applications that involve charging/discharging at low temperatures or deep charging/discharging (SOC between 0% and 100%)

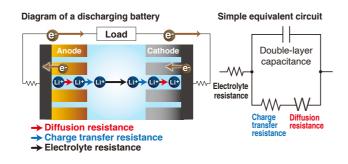




Rel: Electrolyte resistance Rct: Reaction resistance

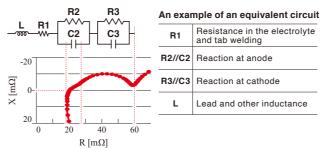
less than 1 Hz	Low frequencies	Li-ion diffusion in the electrode (Diffusion resistance)
1 Hz to several hundred Hz		Li-ion transfer (Charge transfer resistance)
About 1 kHz	High frequencies	Li-ion transport in electrolyte (electrolyte resistance)

BT4560



#### Idenfity battery deterioration factors

An equivalent circuit analysis software (e.g. ZView®\*) can provide the parameters of each element of an equivalent circuit model by means of curve fitting. It allows you to see which part of the battery has shown characteristic changes. This serves to identify battery deterioration factors.



\*ZView® is a product of Scribner Associates, Inc.

For more information about ZView®, please contact Scribner Associates, Inc.

#### surement frequencies and nce i

The BT4560 offers measurements in the optimal frequency range for liquid Li-ion batteries. Its unparalleled capability to measure extremely low impedance is ideal for large cells such as ones for xEVs or ESSs. As a complementary instrument, the IM3590 offers

impedance measurements across a wider frequency range. It is very capable at measuring larger im									
Model		Me	asurement freque	Impedance measurement ranges	Max. Voltage				
IM3590	1 mH	lz to 20	00 kHz			100 mΩ to 100 MΩ	5 V		
BT4560 (Special specifications for 10 kHz)		0.01	Hz to 10 kHz			3 mΩ, 10 mΩ, 100 mΩ	5 V		
BT4560 (Standard specification)			0.1 Hz to 1050 Hz			3 mΩ, 10 mΩ, 100 mΩ	5 V		
BT4560 (Special specifications 1)			0.1 Hz to 1050 Hz			30 mΩ, 300 mΩ	10 V		
BT4560 (Special specifications 2)			0.1 Hz to 1050 Hz			30 mΩ, 300 mΩ, 3 Ω	20 V		
BT4560 (Special specifications 3)		0.01	Hz to 1050 Hz			3 mΩ, 10 mΩ, 100 mΩ	5 V		
BT4560 (Special specifications 4)		0.01	0.01 Hz to 1050 Hz			30 mΩ, 300 mΩ	10 V		
BT4560 (Special specifications 5)		0.01	Hz to 1050 Hz			30 mΩ, 300 mΩ, 3 Ω	20 V		

#### **BT4560 Accuracy specifications**

#### Impedance measurement accuracy

$R = \pm (0.004   R   + 0.0017   X  ) [m\Omega] \pm \alpha R = \pm (0.004   R   + 0.005)$	
The units of <i>R</i> and <i>X</i> are [mΩ], <i>α</i> is as shown below $\begin{aligned} X & accuracy = \pm (0.004   X  + 0.0017   R  ) [mΩ] \pm \alpha \\ X & accuracy = \pm (0.004   X  + 0.0017   R  ) [mΩ] \pm \alpha \\ X & accuracy = \pm (0.004   X  + 0.0017   R  ) [mΩ] \pm \alpha \\ X & accuracy = \pm (0.004   X  + 0.0017   R  ) [mΩ] \pm \alpha \\ X & accuracy = \pm (0.004   X  + 0.0017   R  ) [mΩ] \pm \alpha \\ X & accuracy = \pm (0.004   X  + 0.0017   R  ) [mΩ] \pm \alpha \\ X & accuracy = \pm (0.004   X  + 0.0017   R  ) [mΩ] \pm \alpha \\ X & accuracy = \pm (0.004   X  + 0.0017   R  ) [mΩ] \pm \alpha \\ X & accuracy = \pm (0.004   X  + 0.0017   R  ) \\ Z & accuracy = \pm (0.004   X  + 0.0017   X ) \\ Z & accuracy = \pm (0.004   X  + 0.0017   X ) \\ Z & accuracy = \pm (0.004   X  + 0.0017   X ) \\ Z & accuracy = \pm (0.004   X  + 0.0017   X ) \\ Z & accuracy = \pm (0.004   X  + 0.0017   X ) \\ Z & accuracy = \pm (0.004   X  + 0.0017   X ) \\ Z & accuracy = \pm (0.004   X  + 0.0017   X ) \\ Z & accuracy = \pm (0.004   X  + 0.0017   X ) \\ Z & accuracy = \pm (0.004   X  + 0.0017   X ) \\ Z & accuracy = \pm (0.004   X  + 0.0017   X$	52   <i>i</i> 9   + 9   +
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	m(
FAST 25 dgt 60 dgt 60 d	
α MED 15 dgt 30 dgt 30 d	
SLOW 8 dgt 15 dgt 15 d	-

	$\begin{array}{l} R: \pm R \text{ accuracy} \times 0.1 \ / \ ^{\circ}\text{C}, X: = \\ \theta: \pm \theta \text{ accuracy} \times 0.1 \ / \ ^{\circ}\text{C} \ \text{(App} \end{array}$	

#### Measurement probes and specialized jigs



\*1: See pages 22 and 23 for compatible probes

\*2: Special-order product. \*3: Used when combining the BT4560 with the SW1001/SW1002 and SW9002.

#### BT4560, IM3590

npedance.

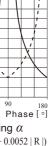


IM3590 CHEMICAL IMPEDANCE ANALYZER



BT4560 BATTERY IMPEDANCE METER

|X|) [m $\Omega$ ]  $\pm \alpha$ |R|) [m $\Omega$ ]  $\pm a$  $|\cos\theta|$  $|\cos\theta|$ 



#### Voltage measurement accuracy (when self-calibration is performed)

ι	v	Display range	-5.10000 V to 5.10000 V	
,	v	Resolution	10 µV	
•	Voltage accuracy	FAST/MED/SLOW	±0.0035% rdg ±5 dgt	
	Temperature	±0.0005% rdg ±1 dg	jt∕°C	
	coefficient	(applied in the ranges of	f 0°C to 18°C and 28°C to 40°C)	

### Temperature measurement accuracy

(BT4560 + Z2005 temperature sensor)

Accuracy	±0.5°C (measurement temperature: 10.0°C to 40.0°C) ±1.0°C (measurement temperature: -10.0°C to 9.9°C, 40.1°C to 60.0°C)		
Temperature coefficient	$\pm 0.01^{\circ}\text{C}/^{\circ}\text{C}$ (applied in the ranges of 0°C to 18°C and 28°C to 40°C)		

The number of waveforms

	FAST	MED	SLOW
0.10 Hz to 66 Hz	1 wave	2 waves	8 waves
67 Hz to 250 Hz	2 waves	8 waves	32 waves
260 Hz to 1050 Hz	8 waves	32 waves	128 waves

0°C)

Cables are also available on a special-order basis Please contact HIOKI for more information

#### Test fixture for cylindrical batteries to use with the Pin Type Probe L2003



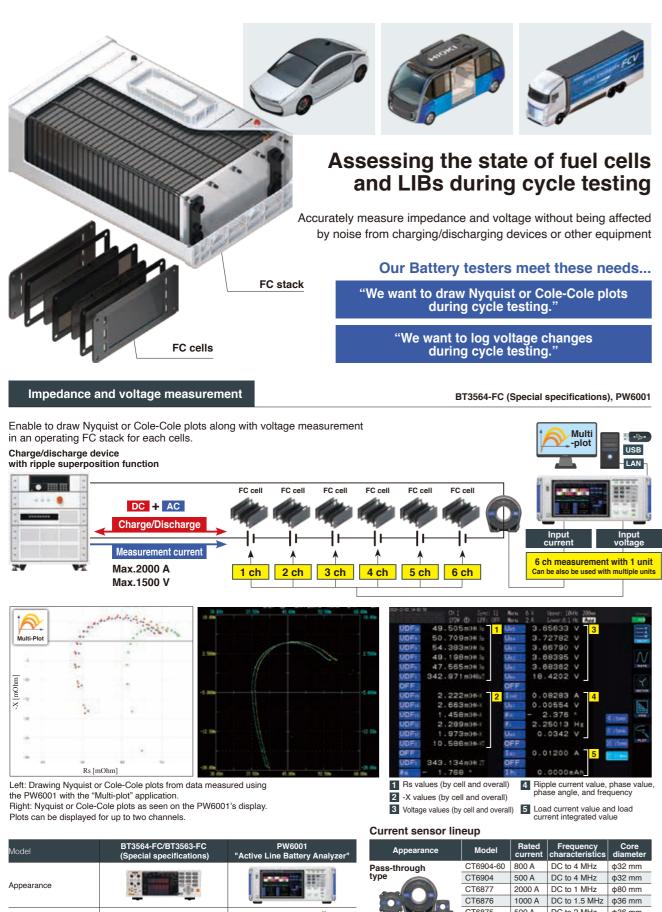


For securing 1 cell'2"3 For securing up to 6 cells'2"3 With batteries attached Connection cord '2"3 (Accommodates 18650, 21700, 4680 and 26650 size cells.)

19

## Analyzing fuel cells (FCs)

BT3564-FC (Special specifications), PW6001



Measurement frequency 1 kHz 0.1 Hz to 300 kHz<sup>-2</sup> Clamp type Max. measurement voltage 1000 V (BT3564-FC)/300 V (BT3563-FC) 1500 V (voltage to earth: 1000 V) Max. allowable input current Not specified 2000 A Number of channels 1 ch

(Maximum allowable voltage: 60 V DC) \*2: Plans to support 0.01Hz

1 ch to 6 ch (× Number of units in use) \*1: The number of channels can be increased using the SW1001/SW1002.

1000 A DC to 1.5 MHz 036 mm CT6875 500 A DC to 2 MHz \$\phi36 mm\$ CT6841-05 20 A DC to 1 MHz 
\$\overline{20} mm\$ CT6843-05 200 A DC to 500 kHz φ20 mm CT6844-05 500 A DC to 200 kHz \$\phi20 mm\$ CT6845-05 500 A DC to 100 kHz 050 mm

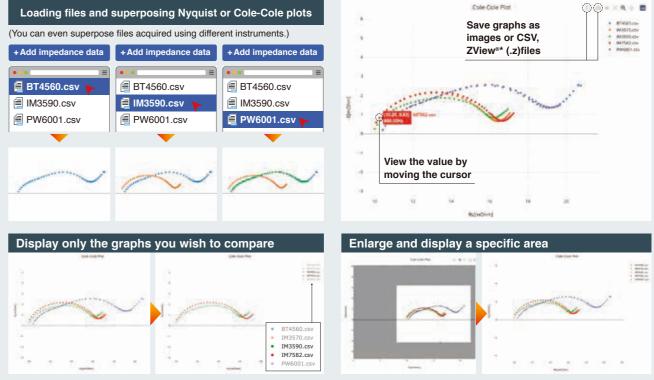
CT6846-05 1000 A DC to 20 kHz 050 mm

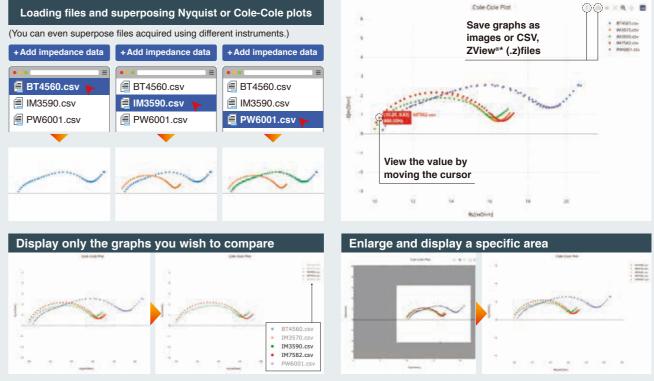
HIOKI Hung Mattern Street famile -00 A Multi-plot (Beta) Multi-plot 回熟的回 **3**33 HIOK



Draw Nyquist or Cole-Cole plots freely, without any limits on the number of points that can be rendered from files or the number of graphs that can be superposed. The horizontal and vertical axes are automatically scaled based on the graphs being rendered. You can even superpose, compare, and analyze files acquired using different instruments

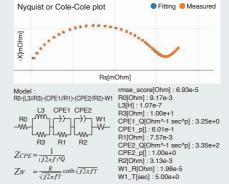
BT4560





### Analysis function

## Conduct an equivalent circuit analysis



Analyze the data with predefined models. Display analysis results automatically assess phase characteristics. simply by loading a file.

phase characteristics

### Web application "Multi-plot"

### **Converting measurement data** into a Nyquist or Cole-Cole plot

web browser link

https://www.circuitfitting.net/multiplot

"Multi-plot", a free web application, enables you to draw

a Nyquist or Cole-Cole plot simply by loading a file in your web browser. Supported files: CSV file, ZView®\* (.z) file

Supported instruments: BT4560, PW6001, IM3536, IM3570, IM3590, IM758x



Draw Bode plots to assess Analyze characteristics with 3D view 101.0 ----Rotate the graph in 3D Bode plots are also drawn, enabling to Draw 3D Nyquist or Cole-Cole plots or 3D

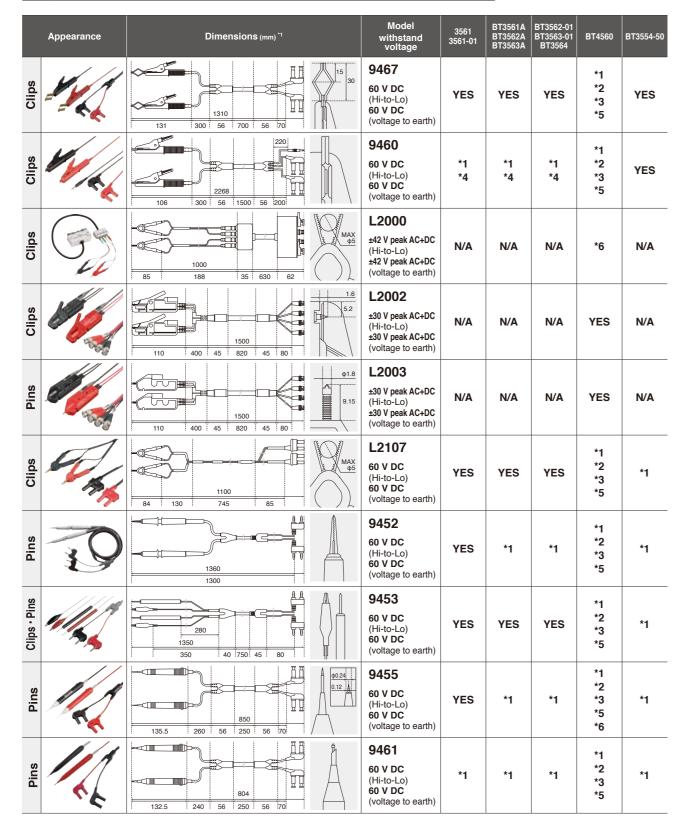
Bode plots, using the time or date as a third axis. Rotate 3D graphs in any direction as desired and save images.

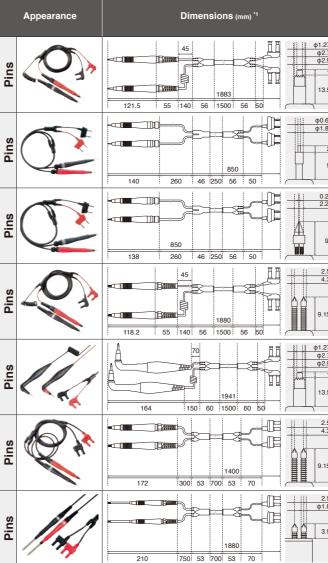
\*ZView® is a product of Scribner Associates, Inc. For more information about ZView®, please contact Scribner Associates, Inc.

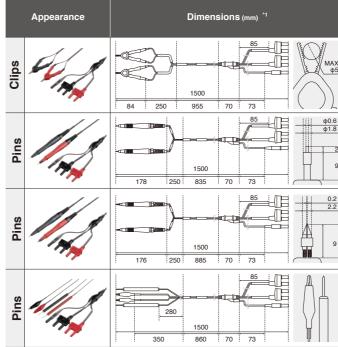
## Measurement lead and measurement probe compatibility chart

- YES : Recommended measurement lead or measurement probe listed in brochures.
- N/A
   Not compatible due to inability to connect.

   \*1
   : Not subject to accuracy guarantee.
- \*2 . May be susceptible to external noise.
- \*2 : May be susceptible to external noise. Caution is particularly required when using a measurement current of 10 mA or less
- \*3 BNC banana plug adapter (See page 19)
- Connect the black banana plugs to the HCUR and HPOT terminals to reduce the influence from external noise.
- \*4 : Temperature sensor cannot be connected.
- \*5 : It does not use a 4-terminal-pair design, so wiring placement will have a greater effect on measured values.
- \*6 : Some measurement ranges cannot be used due to rated current limitations.







\*1: Dimensions other than overall length include typical values.

	Model withstand voltage	3561 3561-01	BT3561A BT3562A BT3563A	BT3562-01 BT3563-01 BT3564	BT4560	BT3554-50
27	<b>9465-10</b> 60 V DC (Hi-to-Lo) 60 V DC (voltage to earth)	*1	*1	*1	*1 *2 *3 *5	YES
.6 .8 2 9	<b>9770</b> <b>60 V DC</b> (Hi-to-Lo) <b>60 V DC</b> (voltage to earth)	YES	YES	YES	*1 *2 *3 *5	*1
9	<b>9771</b> <b>60 V DC</b> (Hi-to-Lo) <b>60 V DC</b> (voltage to earth)	YES	YES	YES	*1 *2 *3 *5	*1
15	<b>9772</b> <b>60 V DC</b> (Hi-to-Lo) <b>60 V DC</b> (voltage to earth)	*1	*1	*1	*1 *2 *3 *5	YES
27	L2020 60 V DC (Hi-to-Lo) 60 V DC (voltage to earth)	*1	*1	*1	*1 *2 *3 *5	YES
15	L2100 1000 V DC (Hi-to-Lo) 1000 V DC (voltage to earth)	*1	YES	YES	*2 *3 *5	*2
.5	L2110 1000 V DC (Hi-to-Lo) 1000 V DC (voltage to earth)	*1	YES	YES	N/A	N/A

	Model withstand voltage	3561 3561-01	BT3561A BT3562A BT3563A	BT3562-01 BT3563-01 BT3564	BT4560	BT3554-50
	<b>L2101*</b> <sup>2</sup> <b>60 V DC</b> (Hi-to-Lo) <b>60 V DC</b> (voltage to earth)	*2	*2	*2	*2 *3 *5	*2
<u>6</u> 8 2 9	L2102 <sup>*2</sup> 60 V DC (Hi-to-Lo) 60 V DC (voltage to earth)	*2	*2	*2	*2 *3 *5	*2
9	L2103*2 60 V DC (Hi-to-Lo) 60 V DC (voltage to earth)	*2	*2	*2	*2 *3 *5	*2
	<b>L2104<sup>*2</sup></b> <b>60 V DC</b> (Hi-to-Lo) <b>60 V DC</b> (voltage to earth)	*2	*2	*2	*2 *3 *5	*2

## Batteries are a driving force for a variety of innovations as we move towards a sustainable society

Batteries are used in an array of applications, and their performance can be a driving force for a variety of innovations and new lifestyles. The development and production of high-quality batteries will play an essential role as we work to realize a sustainable society. At the same time therefore, growing improvements in battery life cycle assessment have become a major priority. the focus on reducing CO2 emissions throughout the entire life cycle by means of improvements in manufacturing processes and reuse of high-quality batteries is increasing. HIOKI battery testers are helping resolve these issues through an electrical measurement approach.

Stacked battery voltage, Internal resistance of battery cells



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